InGaP HBT Gain Block

Product Features

- DC 6000 MHz
- +19 dBm P1dB at 900 MHz
- +33.5 dBm OIP3 at 900 MHz
- 14 dB Gain at 900 MHz
- Single Voltage Supply
- Green SOT-86 SMT Package
- Internally matched to 50 Ω

Applications

- Mobile Infrastructure
- CATV / DBS
- W-LAN / ISM
- RFID
- Defense / Homeland Security
- Fixed Wireless

Product Description

The AG602-86 is a general-purpose buffer amplifier that offers high dynamic range in a low-cost surface-mount package. At 900 MHz, the AG602-86 typically provides 14 dB gain, +33.5 dBm OIP3, and +19 dBm P1dB. The device combines dependable performance with consistent quality to maintain MTBF values exceeding 100 years at mounting temperatures of +85 °C & is housed in a SQT-8 industry-standard SMT lead-free/green/RoHS-com package.

The AG602-86 consists of Darlington pair amplificusing the high reliability InGaP/GaAs HBT process and only requires DC-blocking capacitors, a and an inductive RF choke for operation.

The broadband MMIC amplifier can be various current and next generation wh such as GPRS, GSM, CDMA, and CDMA. the AG602-86 will work for other within the DC to 6 GHz freq and fixed wireless.

Funct 2

Funer	Pin No.
<u>~ ~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~</u>	1
O Bias	3
ound	2, 4

Typical 1

900

13.8

-13

-17

+19.0

+33.7

4.5

-12

-17

+19.0

+33.9

4.5

1900

12.9

-17

-16

+18.7

+33.5

4.6

2140

12.7

-16

-15

+18.7

+33.3

4.6

pecifications (1)		Total Poformance	1)
Parameter	Units	Min	Ty ax Gram Units	
Operational Bandwidth	MHz	DC	5000 reque MHz 500	
Test Frequency	MHz		S21 dB 14.0	

Operational Bandwidth	MHZ	DC		\$000C	1
Test Frequency	MHz		(0)	· _	,
Gain	dB			⊘	١
Input Return Loss	dB		$\mathcal{V}_{\mathcal{B}}$	R	•
Output Return Loss	dB	20	<u> </u>		
Output IP3 (2)	dBm		+19.		(
Output IP2	dBm کے		+3(7)		2
Output P1dB	dBn/ C				
Noise Figure	A.	> ~ (
Test Frequency	$\mathcal{N}(\mathcal{O})$		¥3007		
Gain		ЦO	12	13.9	
Output IP3 (2)	$\sim 10^{-1}$		(1) (1) (1) (1) (1) (1) (1) (1) (1) (1))	
Output P1dB	/dBm	(0)	(K)		
Device Voltage	$\sim v < \sim$		3.16		
Device Curren	Part -	\mathcal{L}	75		
	$\sim \sim$,		

- 1. Test conditions:
- 2 3OIP measured he 3OIP using a 2:1 rule.

Absolute N

Parame	Rating	
Operating Case Te Toure	-40 to +85 °C	
Storag per co	-55 to +125 °C	
DC Color	+7 V	
R Power continuous)	+10 dBm	
n Tegerature	+250° C	

Ordering Information

dB

dB

dBm

dBm

dΒ

utput P1dB

Output IP3

Noise Figure

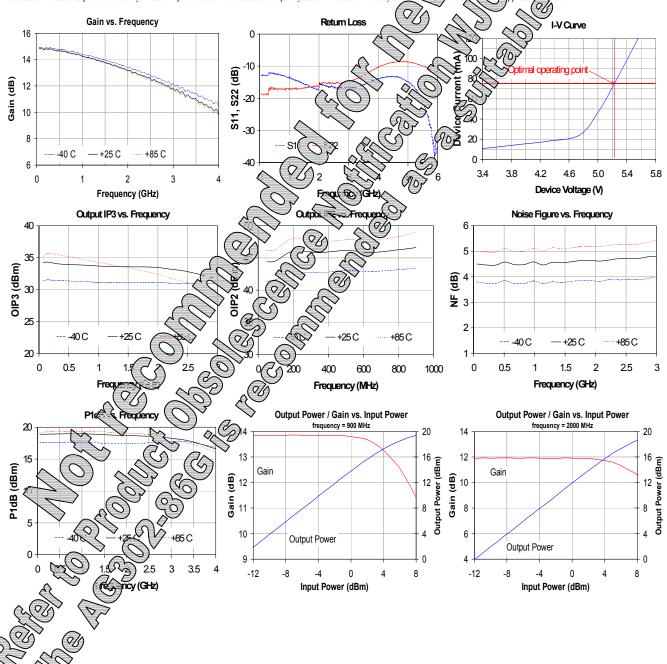
Part No.	Description
AG602-86	InGaP HBT Gain Block (lead-tin SOT-86 Pkg)
AG602-86G	InGaP HBT Gain Block (lead-free/green/RoHS-compliant SOT-86 Pkg)

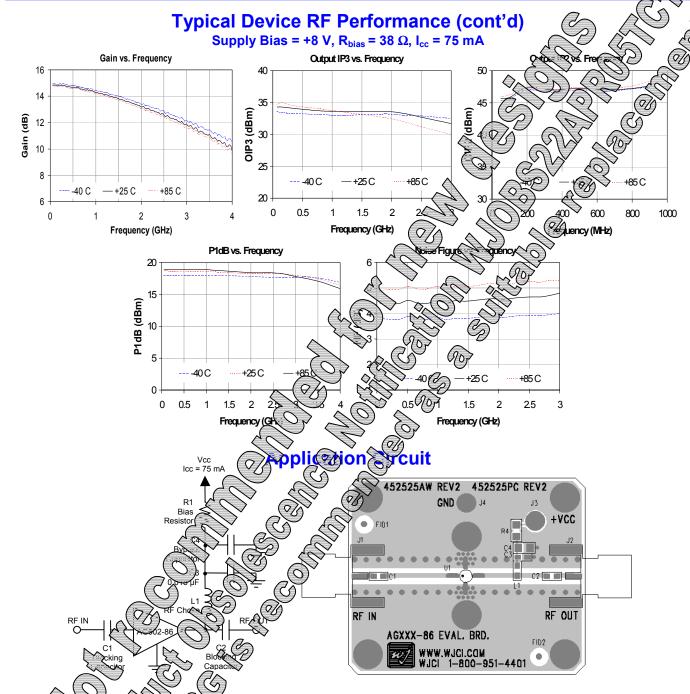
above any of these parameters may cause permanent damage.

Typical Device RF Performance Supply Bias = +6 V, R_{bias} = 11.2 Ω , I_{cc} = 75 mA

Frequency	MHz	100	500	900	1900	2140	2400	35(
S21	dB	14.2	14.0	13.8	12.9	12.7	12.4	\checkmark
S11	dB	-12	-12	-13	-17	-16	-16	
S22	dB	-19	-17	-17	-16	-15	-15	$\mathcal{S}_{\mathcal{C}}$
Output P1dB	dBm	+18.9	+19.0	+19.0	+18.7	+18.7	C18 0	6) 17
Output IP3	dBm	+34.2	+33.9	+33.7	+33.5	+33.3	(62)	
Noise Figure	dB	4.5	4.5	4.5	4.6	4.6	/an	

Test conditions: T = 25° C, Supply Voltage = +6 V, Device Voltage = 5.16 V, Rbias = 11.2 Ω, Icc = 75 mA typical, 50 Ω Systet
 30IP measured with two tones at an output power of +2 dBm/tone separated by 10 MHz. The suppression on the largest IM3 pt
 Data is shown as device performance only. Actual implementation for the desired frequency band will be determined by external process.





Referency (MHz)									
Designat	500	500	900	1900	2200	2500	3500		
L1	(O)	Hex((Q)	68 nH	27 nH	22 nH	18 nH	15 nH		
C1, C2, C4	.0\SμF	pF	100 pF	68 pF	68 pF	56 pF	39 pF		

Recommen

are dependent upon the intended frequency of operation.
on the evaluation board to achieve optimal broadband performance:

~ ~~	Ref/Jy ic.	Value / Type	Size
	LL	39 nH wirewound inductor	0603
35	(D)	56 pF chip capacitor	0603
)	C3	0.018 μF chip capacitor	0603
(QZY4	Do Not Place	
Z,	K1	10.0 Ω 1% tolerance	0805
Z)			

Pacammandad Rias Pasistar Values

S upply Voltage	R1 value	Size		
6 V	11.2 ohms	0805		
7 V	24.5 ohms	1210		
8 V	38 ohms	1210		
9 V	51 ohms	2010		
10 V	65 ohms	2010		
12 V	91 ohms	2512		

The proper value for R1 is dependent upon the supply voltage and allows for bias stability over temperature. WJ recommends a minimum supply bias of +6 V. A 1% tolerance resistor is recommended.

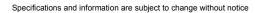


Typical Device Data

S-Parameters (V_{device} = +5.16 V, I_{CC} = 75 mA, T = 25° C, calibrated to device leads)

o rarameters (device 0.10	,, ,, ,, ,, ,, ,,		rorated to de ite	e reads)			
Freq (MHz)	S11 (dB)	S11 (ang)	S21 (dB)	S21 (ang)	S12 (dB)	S12 (ang)	4 50	SE (TELET
50	-12.83	177.09	14.80	177.77	-18.80	0.08	(0)	
250	-12.82	170.56	14.74	169.43	-18.86	-1.92	(Co. 10)	Q:20
500	-12.28	160.75	14.65	159.21	-18.96	-3.46	-3.03	Z-179.93 _(C
750	-12.95	151.18	14.52	149.21	-18.85	-6.03	2 17.02	178.2
1000	-13.42	141.09	14.36	139.36	-18.99	~9.(\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	-1767	-177
1250	-14.45	130.22	14.20	129.61	-18.80		(X)8/\)	< 2007
1500	-15.66	118.89	13.96	119.96	-18.74	(60)	76/6	717
1750	-16.63	107.21	13.72	110.48	-18.72			0.21
2000	-17.29	91.44	13.45	101.21	-18.72	-17.16	TO.05	7 171.46
2250	-16.20	64.73	13.13	92.69	-18.62	19.12	15.30	-157.61
2500	-16.75	61.88	12.95	85.98	-18,62	-200) -15 <i>2</i>	-166.73
2750	-16.88	58.51	12.66	77.40	-1(G)	-22.1		-178.65
3000	-16.78	58.02	12.38	68.87		CARO, V	~ A	164.02
3250	-16.66	58.65	12.09	60.40	(D)	(1) for	9.96	147.18
3500	-15.78	60.29	11.76	52.22	+ 42	-30:43	70, 12.75	131.66
3750	-14.83	64.00	11.38	43.53	-18.13	₩33.00 E	-11.49	119.00
4000	-14.00	65.81	11.02	35.47	-1842	34.9	-10.22	110.33
4250	-13.41	67.18	10.72	(20)	-1	-38	-9.34	103.54
4500	-13.22	67.82	10.44		-1200	-Ø)	-8.83	98.14
4750	-13.66	68.18	10.12	12.5	-5107	-43.83	-8.56	95.06
5000	-14.82	69.02	9.96	5.20	((1))	P0747.93	-8.67	93.79
5250	-17.08	69.30	9.80	V-12.71	1.22	-50.61	-9.09	92.99
5500	-20.92	70.38	2.72(C)	-8.45	>- 17.00 ○	-52.28	-9.99	93.56
5750	-28.67	80.98	M	J -15.72	-16/707	-56.37	-10.93	93.36
6000	-36.06	162.23	(0)	(0).50	6.48	-58.54	-12.13	92.07
			- 1 - 1	\sim				

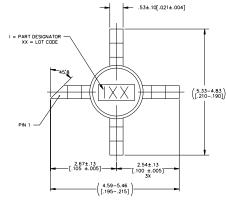
Device S-parameters at an le for down d off website at: http://www.wj.com

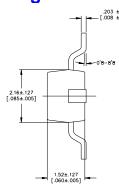


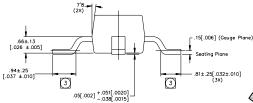
AG602-86 (SOT-86 Package) Mechanical Inform

This package may contain lead-bearing materials. The plating material on the leads is S

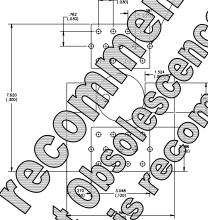
Outline Drawing







Land Patte



Therma

Junction Tempe

- 165 °C
- 1. The thermal r ed from the hottest part of the jund ad (pin 2 or 4).
- 2. This correst cical biasing condition of mA at \$20 5 °C case temperature. million hours is achieved for below 177 °C.

for this part are the "Application

Caution! ESD sensitive device.

iting: Class 0 Passes at 150 V

Human Body Model (HBM) JEDEC Standard JESD22-A114 tandard:

ESD Rating: Class II

Passes at 250 V Value:

Charged Device Model (CDM) Test: JEDEC Standard JESD22-C101 Standard:

MSL Rating: Level 1

Standard: JEDEC Standard J-STD-020A

Mounting Config. Notes

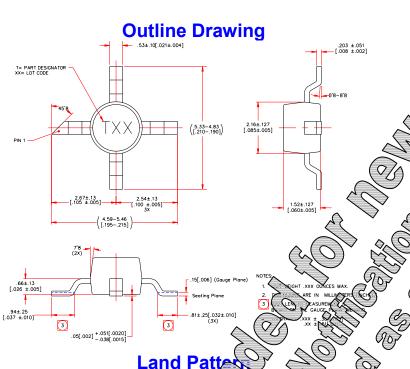
- 1. Ground / thermal vias are critical for the proper performance of this device. Vias should use a .35mm (#80 / .0135") diameter drill and have a final plated thru diameter of .25 mm (.010").
- Add as much copper as possible to inner and outer layers near the part to ensure optimal thermal performance.

 3. Mounting screws can be added near the part to fasten the
- board to a heatsink. Ensure that the ground / thermal via region contacts the heatsink
- 4. Do not put solder mask on the backside of the PC board in the region where the board contacts the heatsink.
- 5. RF trace width depends upon the PC board material and
- 6. Use 1 oz. Copper minimum.
- All dimensions are in millimeters (inches). Angles are in

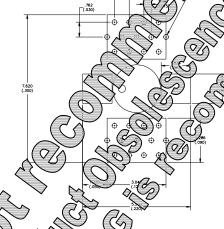


AG602-86G (Green / Lead-free Sot-86 Package) Mechanical

This package is lead-free/Green/RoHS-compliant. It is compatible with both lead-free (maximum 260°C reflormed attraction) and aded (maximum 245°C reflow temperature) soldering processes. The plating material on the pins is annealed with in or solder.



Land Pall



Therm spec sticks

Operating Case Cature 40 to +85 °C
Thermal Resistan Rth 206 °C/W
Junction Temperature, Time 165 °C

1. The thermal that tan defenced from the hottest part of the justion to the bodd lead (pin 2 or 4).

2. This commond the typical biasing condition of +5 mA can 85 °C case temperature. A room MTTF of 1 million hours is achieved for on temperature below 177 °C.

in one of the surface of the package.

rape pecification for this part are local in the "Application No. 100.

MOY ESD Rating

caution! ESD sensitive device.

Rating: Class 1C

Passes at 1000 V min.
Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

ESD Rating: Class IV

Value: Passes at 1000 V min.
Test: Charged Device Model (CDM)
Standard: JEDEC Standard JESD22-C101

MSL Rating: Level 3 at +260° C convection reflow Standard: JEDEC Standard J-STD-020

Mounting Config. Notes

- Ground / thermal vias are critical for the proper performance of this device. Vias should use a .35mm (#80 / .0135") diameter drill and have a final plated thru diameter of .25 mm (.010")
- Add as much copper as possible to inner and outer layers near the part to ensure optimal thermal performance.
 Mounting screws can be added near the part to fasten the
- Mounting screws can be added near the part to fasten the board to a heatsink. Ensure that the ground / thermal via region contacts the heatsink.
- Do not put solder mask on the backside of the PC board in the region where the board contacts the heatsink.
- RF trace width depends upon the PC board material and construction.
- 6. Use 1 oz. Copper minimum.
- 7. All dimensions are in millimeters (inches). Angles are in degrees.